

<b>Notice of References Cited</b>	Application/Control No. 10/587,228		Applicant(s)/Patent Under Reexamination LIU, ENHUI	
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	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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